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ATTY. DOCKET NO.	SERIAL NO.
500.31108CC5	09/712,171
APPLICANT: A. TANAKA et al.	
FILING DATE: November 15, 2000	GROUP: 2184

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NB		4 0 5 3 7 5 2	10/77	DeJohn et al.	------	----------	
		4 3 5 8 8 4 8	11/82	Patel	------	----------	
		4 9 1 4 6 5 6	04/90	Dunphy, Jr. et al.	------	----------	
		4 9 5 8 3 5 1	09/90	Flora et al.	------	----------	
		5 2 7 4 7 9 9	12/93	Brant et al.	------	----------	01/04/91

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
NB	6	3- 1 5 5 4 6 8	06/88	JP	------	----------	Abstract	
		5- 2 5 1 6	01/93	JP	------	----------	Abstract	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

NB		W. Meador, "Disk array systems", Digest of Papers, Compcon '89: Thirty-Fourth IEEE Computer Society International Conference, February 27, 1989, San Francisco, CA, pp. 143-146 (abstract only).

EXAMINER: Scott Baderman DATE CONSIDERED: 9/27/02

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OIPE JC152 AUG 23 2002 PATENT & TRADEMARK OFFICE

ATTY. DOCKET NO.	SERIAL NO.
500.31108CC5	09/712,171
APPLICANT: A. TANAKA et al.	
FILING DATE: November 15, 2000	GROUP: 2184

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

dl		G. Gibson et al., "Failure correction techniques for large disk arrays", Proceedings of the Third International Conference on Architectural Support for Programming Languages and Operating Systems (ASPLOS-III), April 3-6, 1989, Boston, MA, pp. 123-132 (abstract only).
		T. Olson, "Disk array performance in a random IO environment", Computer Architecture News, Vol. 17, No. 5, September 1989, pp. 71-77 (abstract only).
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

NS		P. Chen et al., "Maximizing performance in a striped disk array", Proceedings of the 17th Annual Symposium on Computer Architecture, May 28-31, 1990, Seattle, WA, pp. 322-331 (abstract only).
↓		A. Reddy et al., "Gracefully Degradable Disk Arrays", Proceedings of the 1991 International Symposium on Fault-Tolerant Computing (FTCS 1991), June 25-27, 1991, Montreal, Canada, pp. 401-408.

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